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CONFIRMATION NO. 7630

SERIAL NUMBER 10/717,506	FILING DATE 11/21/2003 RULE	CLASS 714	GROUP ART UNIT 2138	ATTORNEY DOCKET NO. 245696US2
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APPLICANTS
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** CONTINUING DATA ***** *None* *ggj*

** FOREIGN APPLICATIONS ***** *ggj*
 JAPAN 2003-152178 05/29/2003

IF REQUIRED, FOREIGN FILING LICENSE GRANTED
 ** 02/19/2004

Foreign Priority claimed <input checked="" type="checkbox"/> yes <input type="checkbox"/> no 35 USC 119 (a-d) conditions <input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after met Verified and Acknowledged <i>John J. Sabme, Jr.</i> Examiner's Signature <i>ggj</i> Initials	STATE OR COUNTRY JAPAN	SHEETS DRAWING 13	TOTAL CLAIMS 15	INDEPENDENT CLAIMS 1
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TITLE
 Failure analysis method of semiconductor device

FILING FEE RECEIVED 770	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:	<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees (Filing) <input type="checkbox"/> 1.17 Fees (Processing Ext. of time) <input type="checkbox"/> 1.18 Fees (Issue) <input type="checkbox"/> Other _____
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